



PCI Technique for Thermal Absorption Measurements

Ashot Markosyan, Roger Route, Helena Armandula, Martin Fejer *and many others*
from the LIGO team

Absorption Loss Measurements on LIGO Optics



Outline

- **Photothermal Common-Path Interferometer**
- Surface Absorption Measurements on Coated Optics
- Transversal scans through mirror: point data
- Longitudinal scans: surface inspection
- Time scans



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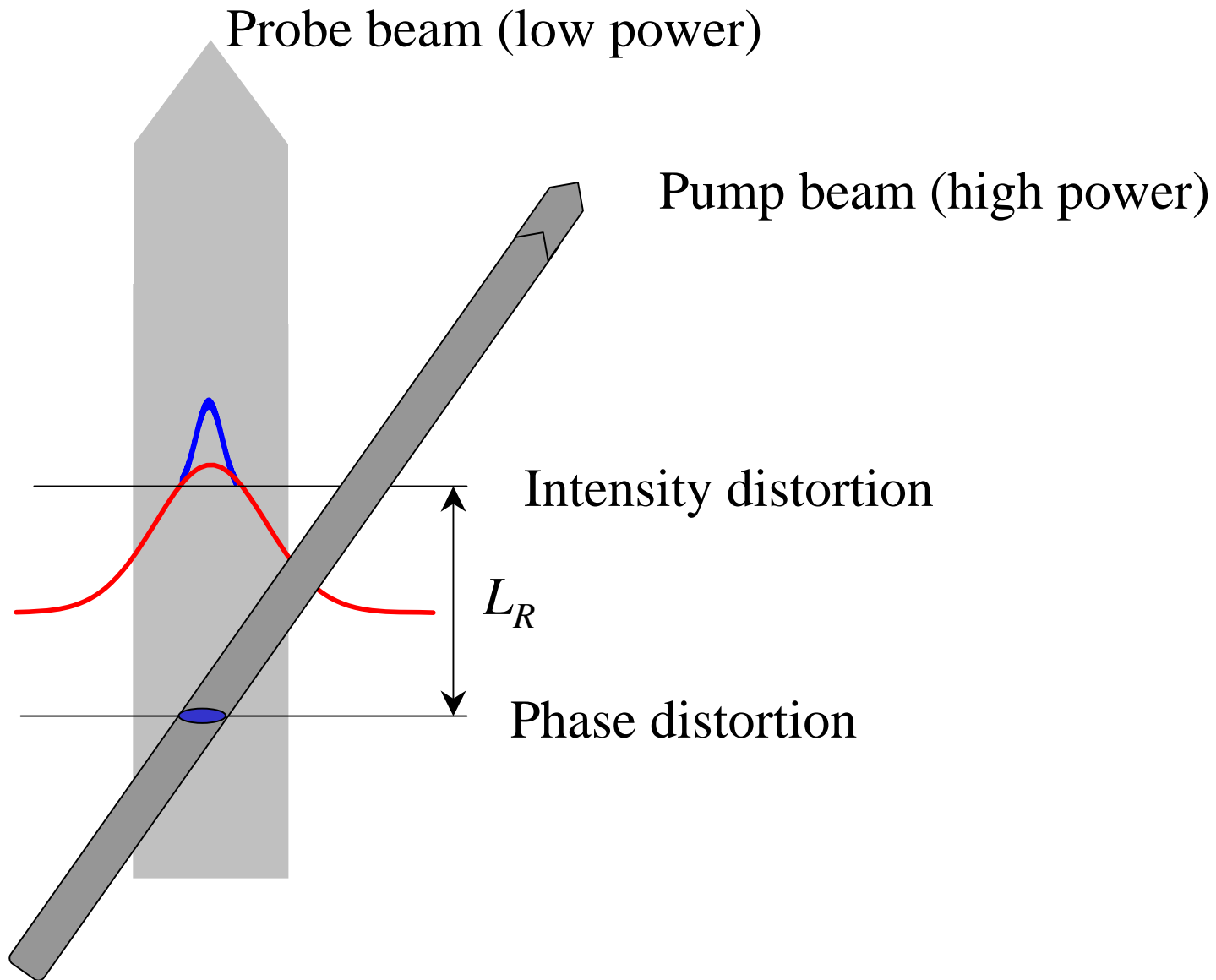


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PCI Method (by Alex Alexandrovsky)





PCI Method

The probe phase is distorted due to heating:

$$\Delta\phi = kL \frac{\partial n}{\partial T} \Delta T$$

$\Delta\phi$ transforms into an intensity distortion.
At the Rayleigh length the intensity modulation is:

$$\Delta I/I_0 = k\delta = (2\pi/\lambda)\Delta nL$$

$$\Delta n = (\partial n/\partial T)\Delta T$$

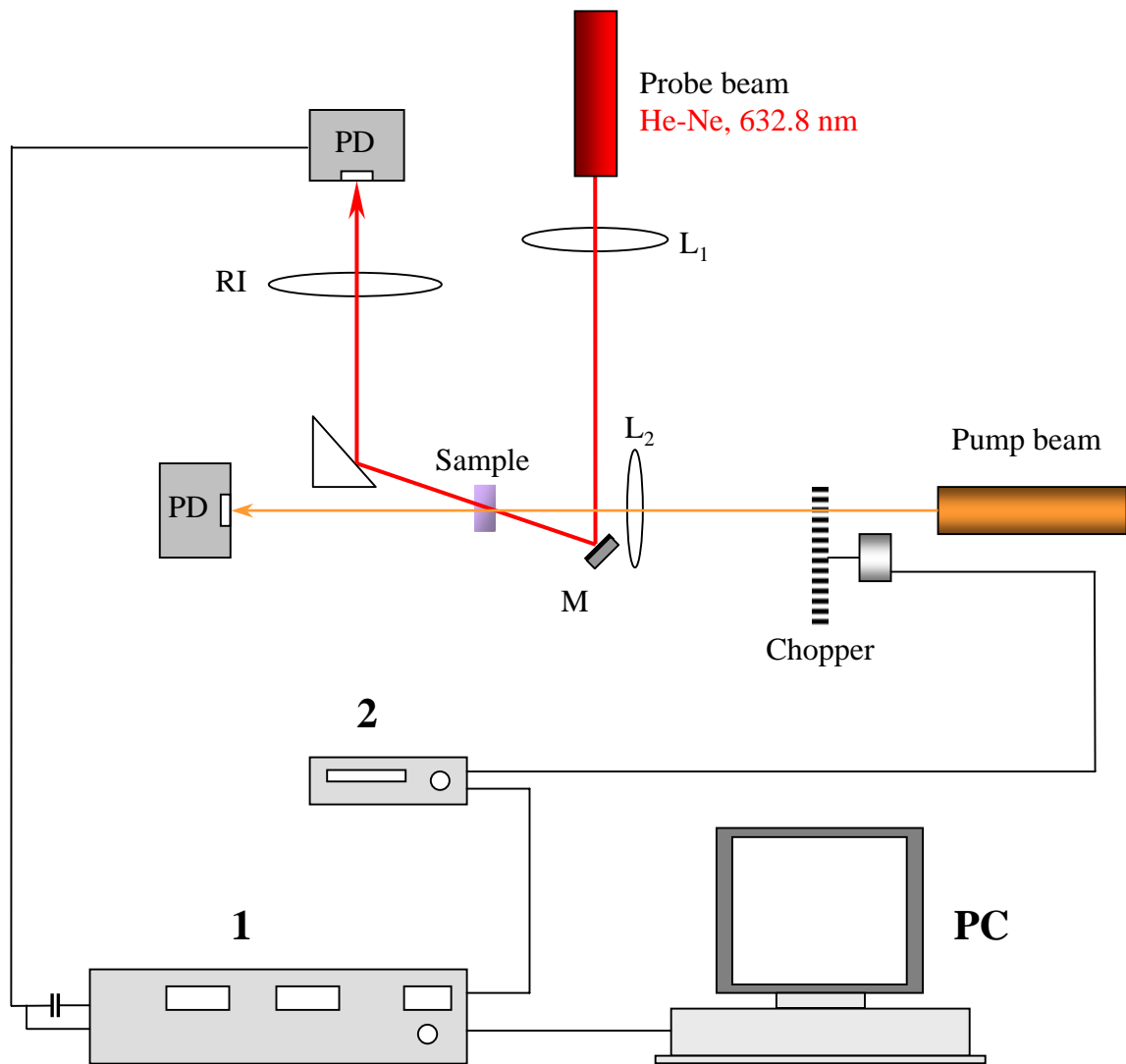
The simplified formula for α with a “chopped” pump beam of power W_p is:

$$\alpha \approx C(\partial n / \partial T)(\lambda / L)(w_0^2 / W_p)(\Delta I / I) f$$



PCI Method

- RI** R-imaging System
- PD** Photodetectors
- L_i** Lenses
- M** Mirror
- 1** Lock-in Amplifier SR830 DSP
- 2** Chopper Controller SR340
- PC** with GPIB-connection (LabVIEW software)





PCI Method

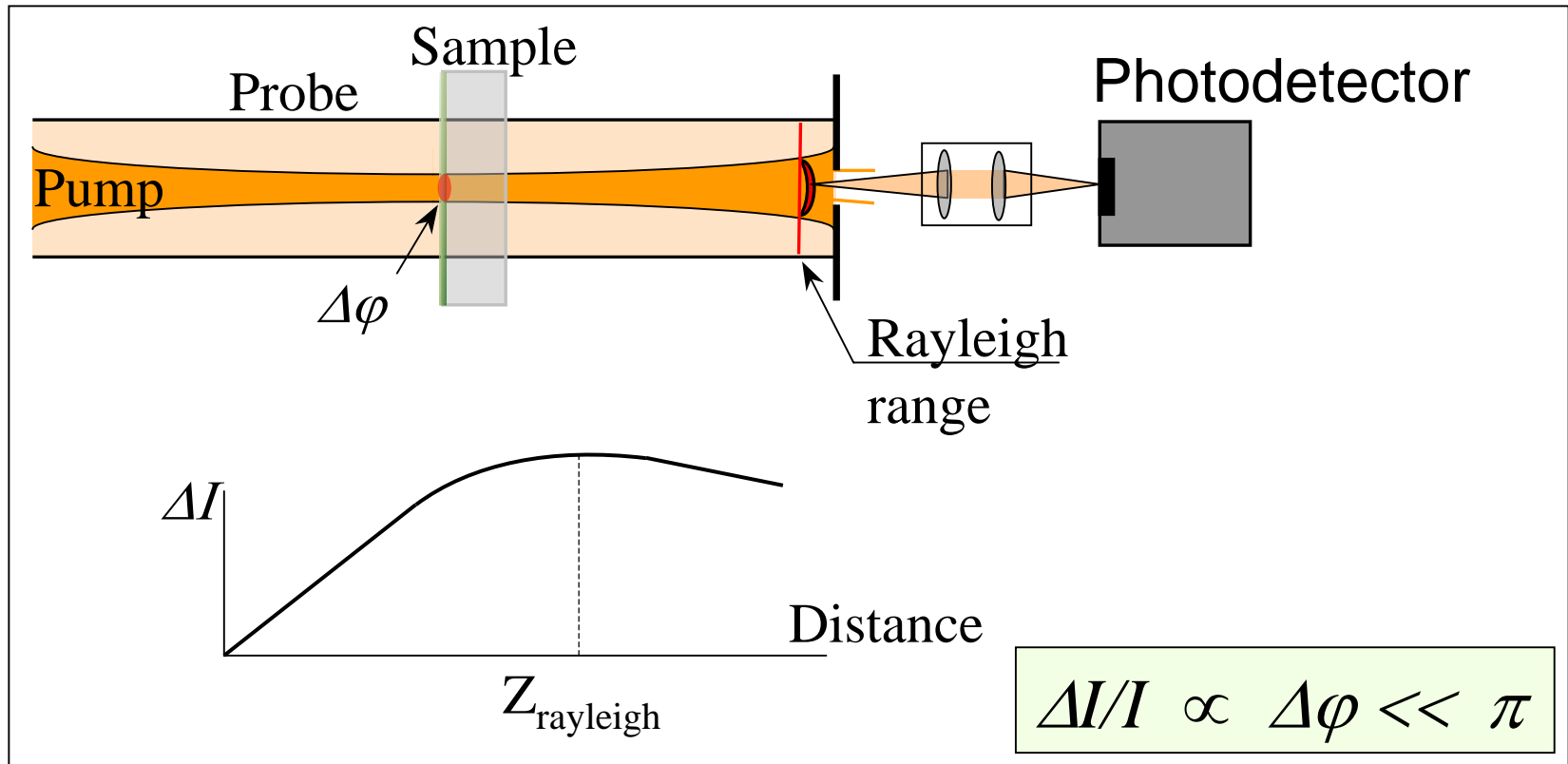


Fig.1. $w_{\text{pump}} < w_{\text{probe}}$. When the pump is on, the probe experiences phase distortion ($\Delta\phi$) in the heated area. At some distance, $\Delta\phi$ transform into ΔI and an effective interference occurs between the central spot (distorted) and outer ring area (undistorted) of the probe

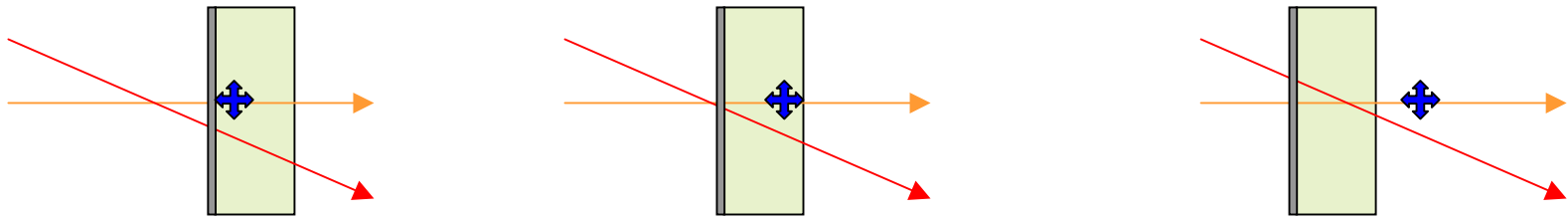


Measurement technique: transversal z -scan (through surface)

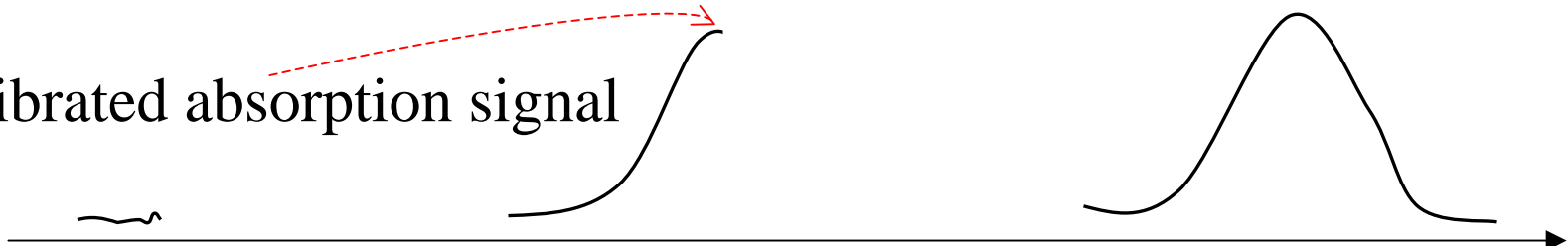
Start position

Maximum Signal

End position



Calibrated absorption signal



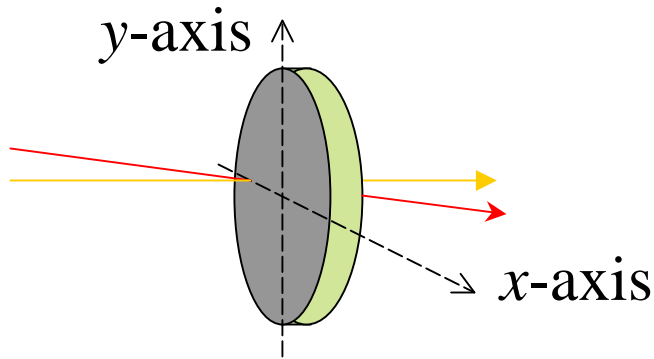
Scanning direction: z -axis

✚ → signal reading point (the focus of the optical system)



Measurement technique: longitudinal x -scan (across surface)

The heated point is positioned at the coated surface



Calibrated absorption signal

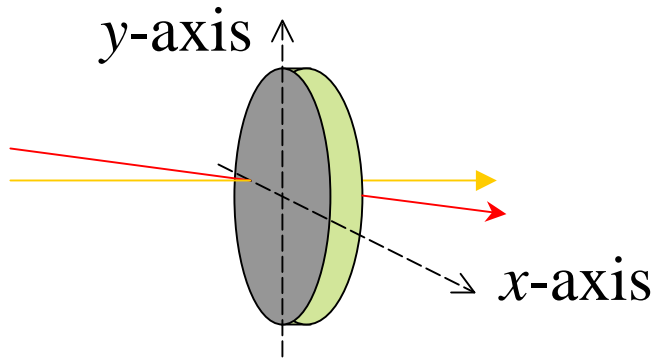
Scanning direction: x -axis





Measurement technique: time scan

The heated point is focused at the coated surface.
The calibrated signal is recorded vs. time elapsed



Calibrated absorption signal

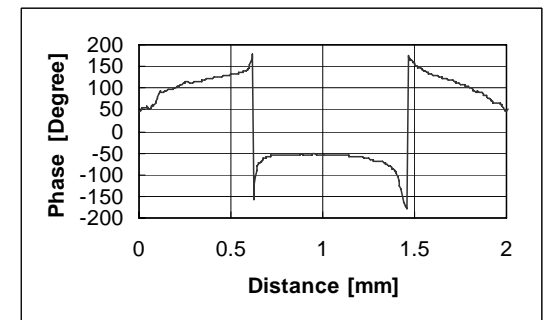
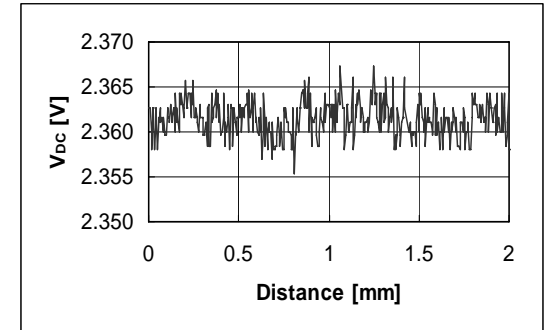
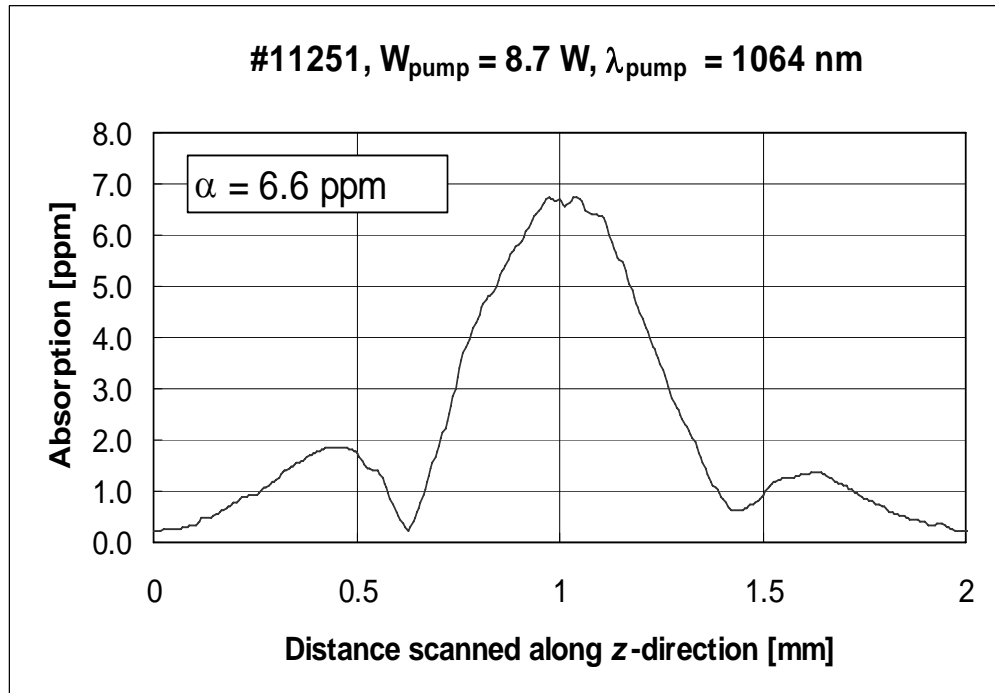


The calibrated signal is recorded vs. the time elapsed

t



HfO₂-SiO₂/SiO₂ coating, $\varnothing = 1$ inch



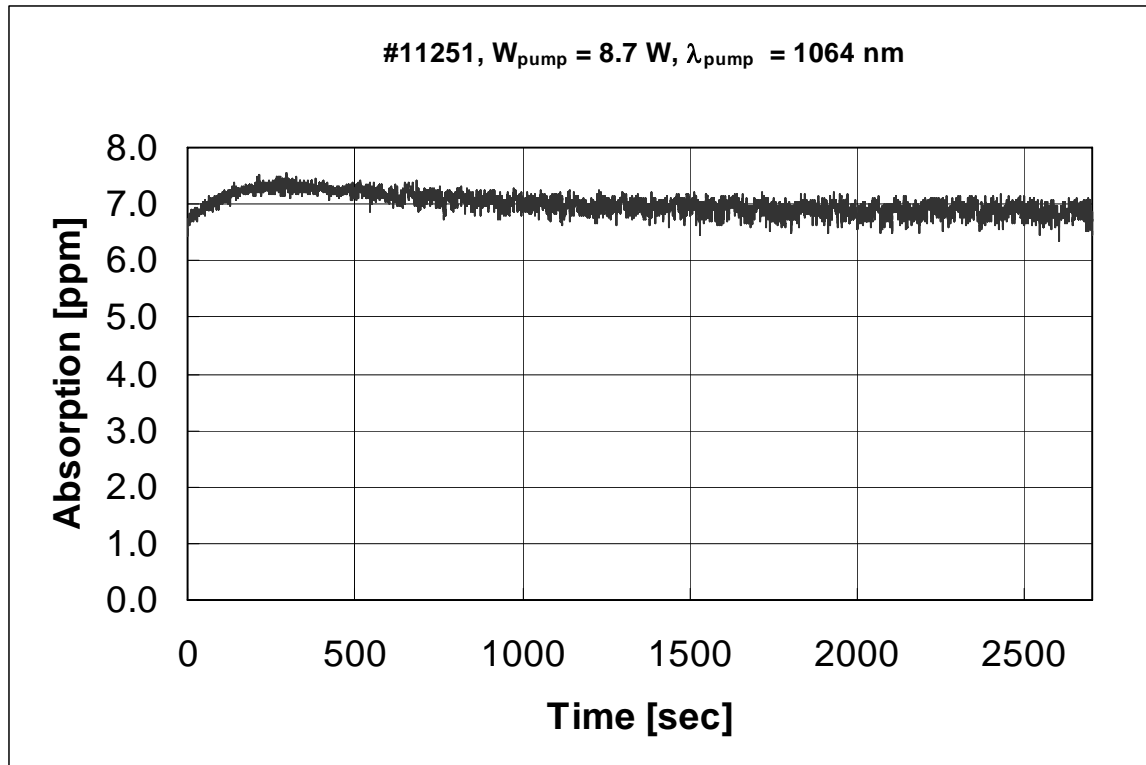
A transversal z -scan of sample #11251.

$$\alpha = 6.6 \text{ ppm.}$$

Additionally monitored parameters : *probe beam stability, phase delay with respect to chopper*



HfO₂-SiO₂/SiO₂ coating, $\varnothing = 1$ inch



A characteristic time dependent 45 min t -scan of sample #11251.

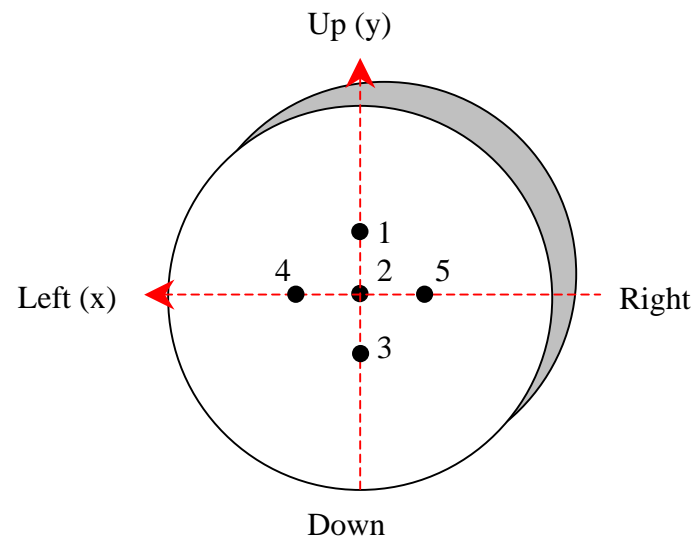
α shows a “bump” (7.3 ppm) at about 5 min.



Tabulated data on series of $\text{HfO}_2\text{-SiO}_2/\text{SiO}_2$ coated samples

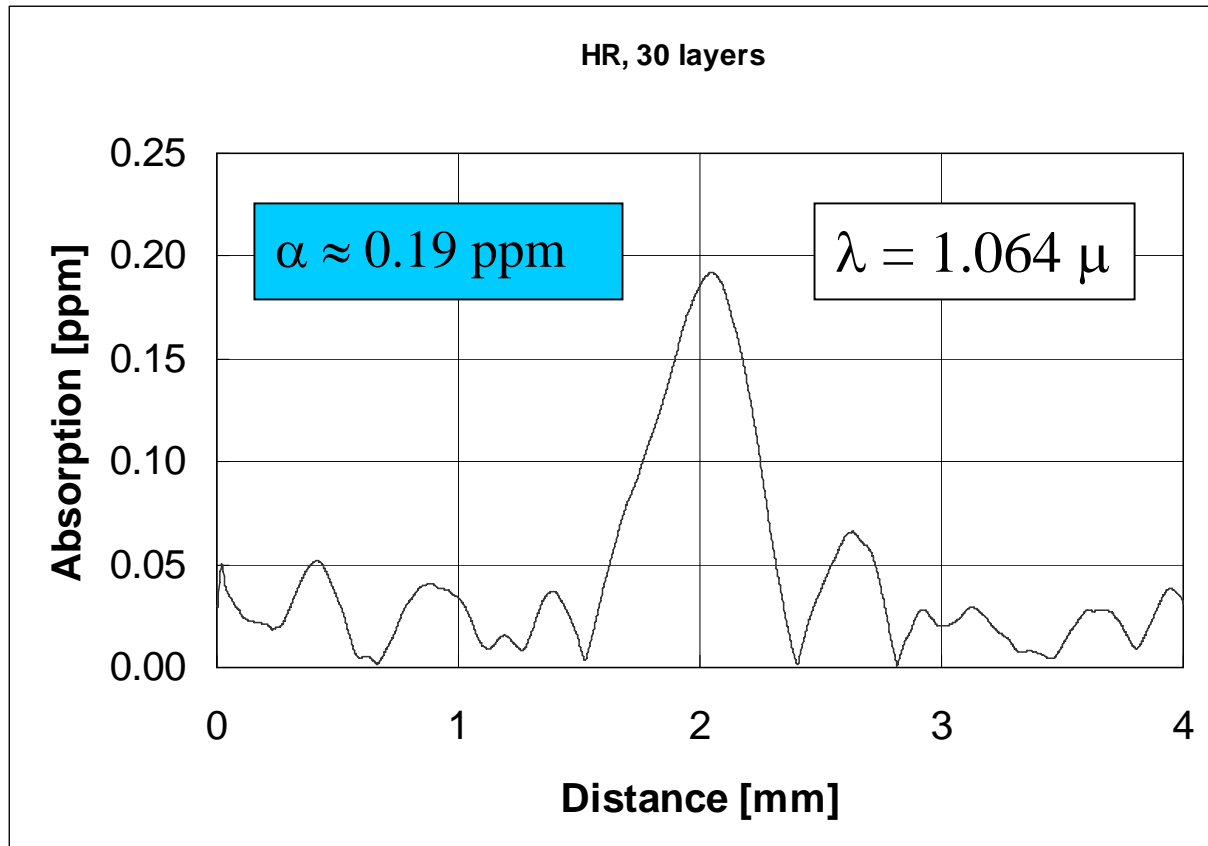
Sample #	Absorption (ppm)					
	3 mm above	Center	3 mm below	3 mm left	3 mm right	Average
014-01	7.2	7.4	7.1	7.1	7.2	7.2
018-01	8.0	8.0	7.9	8.1	7.9	8.0
024-01	6.9	6.7	6.9	6.8	6.9	6.9
11251	6.8	6.4	6.6	6.6	6.6	6.6

Position of measured points





Method's resolution: down to 0.1 ppm with $W_{pump} < 10$ W



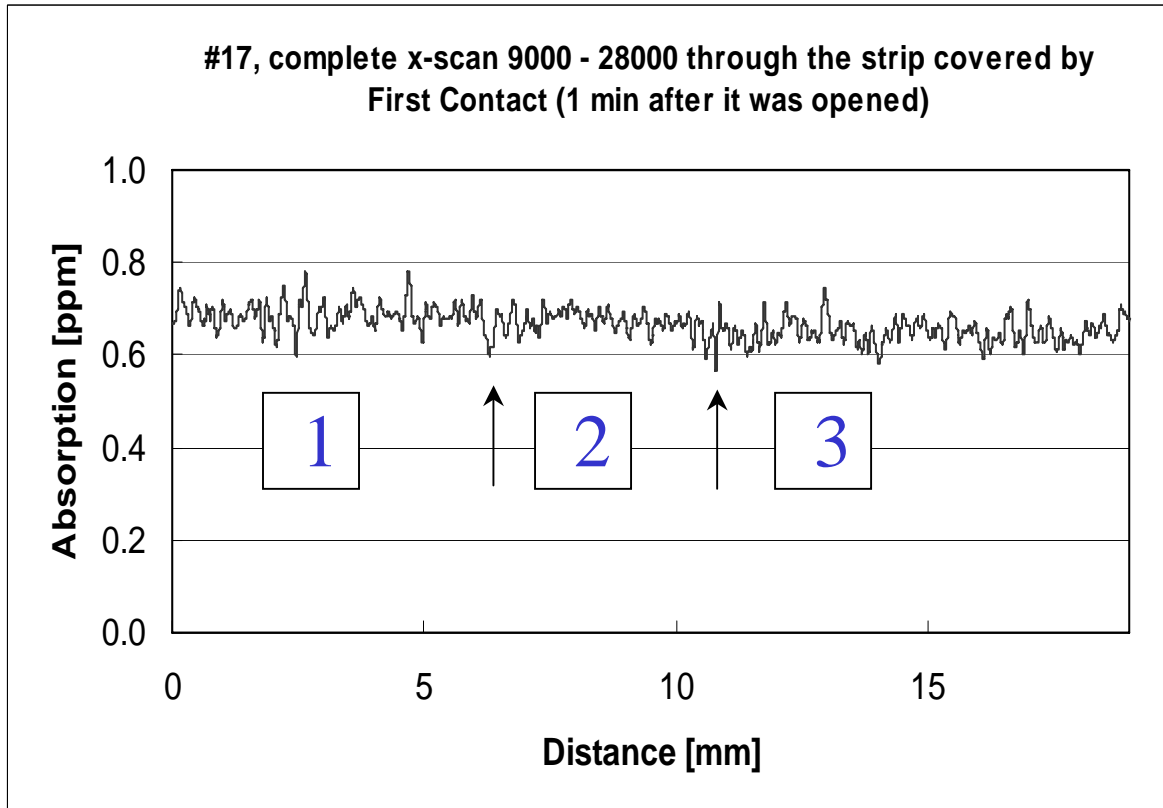
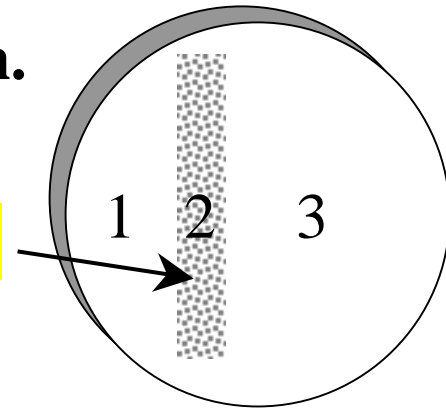
A transversal z -scan of a 30 layer HR mirror on a FS substrate.

$W_{pump} = 8.8$ W, $\lambda = 1.064 \mu$. Absorption measured = 0.19 ppm.



A coated 3 inch disk marked #17, $\alpha = 0.65$ ppm.

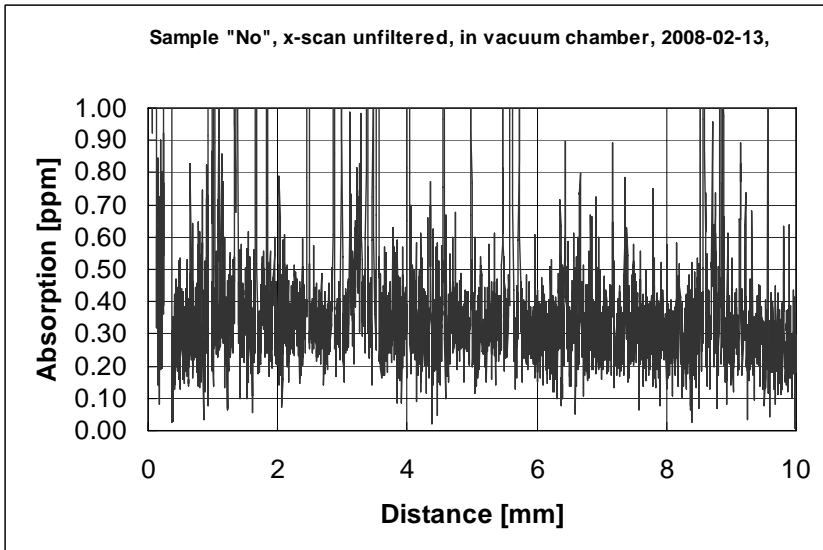
Covered by a First Contact strip for 1 week



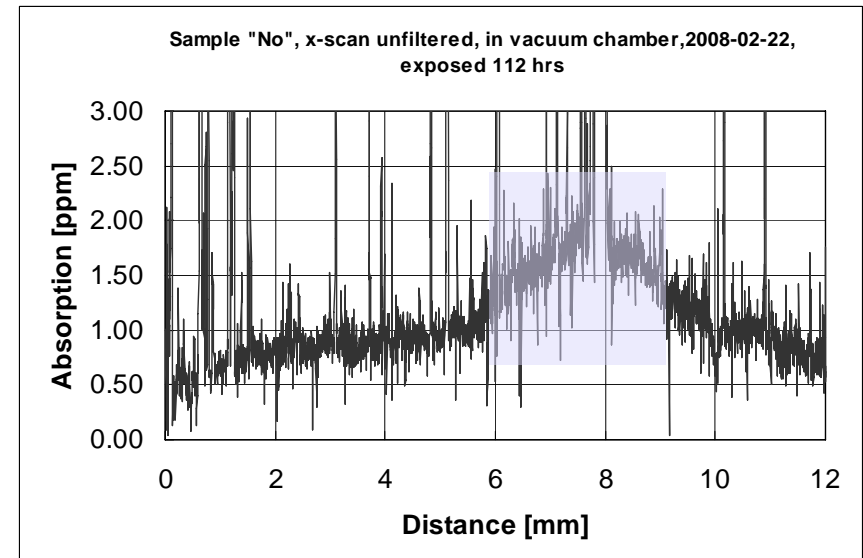
Testing the “First Contact” effect.
 $\alpha = 0.65$ ppm.



Study of the UV illumination effect on LIGO coated mirrors



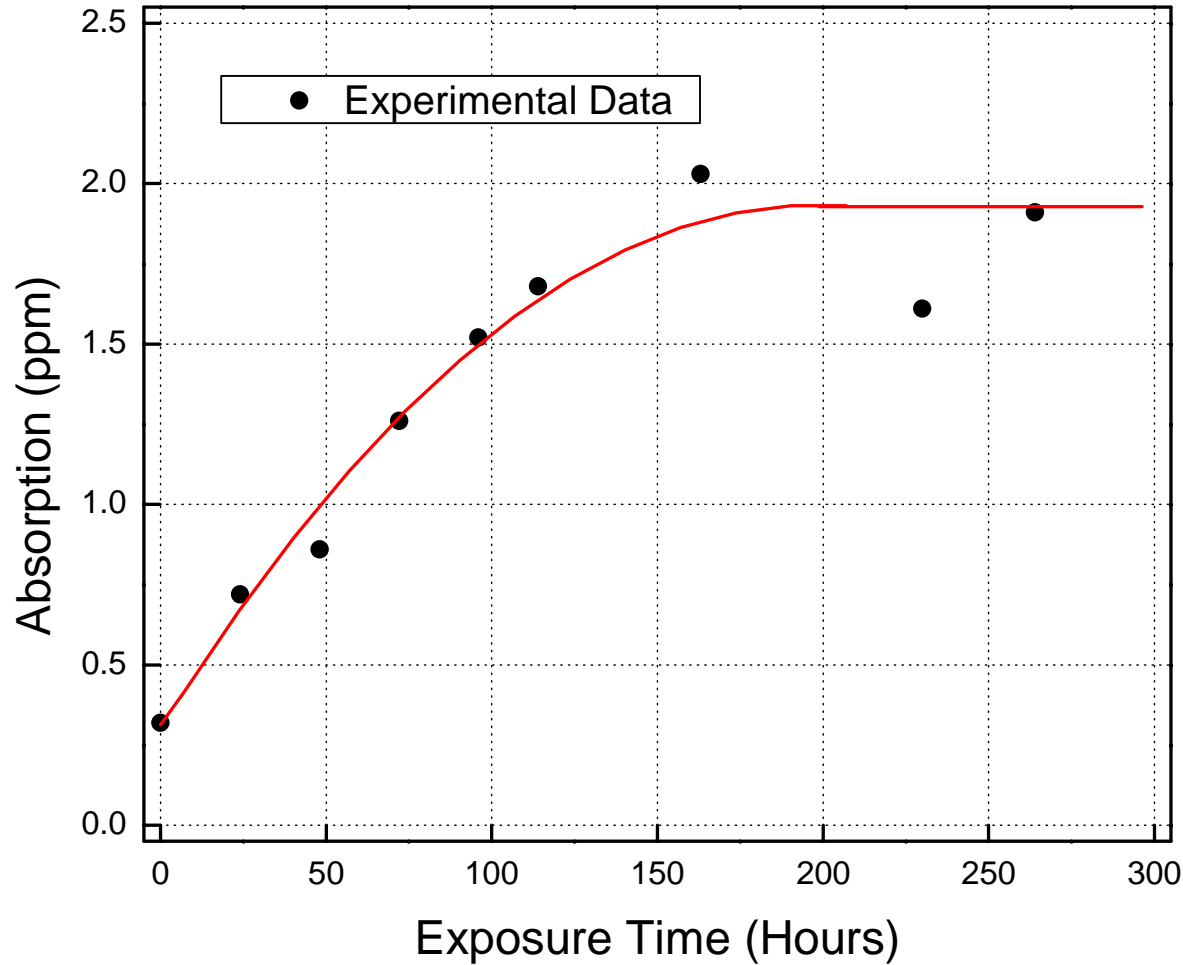
Characteristic x -scans before and after UV illumination (*see Ke-Xun Sun's talk for details*)





Study of the UV illumination effect on LIGO coated mirrors

Sample # "No"



Variation of the absorption loss vs. Exposure Time



Summary

The PCI method is capable to measure thermal absorption losses as low as 0.1 ppm with 8 W incident power

Point by point as well as continuous scan across the coating are possible

The lowest Absorption value measured on LIGO mirrors till now were 0.19 ppm